

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination OKUDA ET AL.	
		Examiner Edward Park	Art Unit 2624	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,035,447 b2	04-2006	Take, Kunihiro	382/145
*	B	US-6,801,650 b1	10-2004	Kikuchi et al.	382/145
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Kuk Wo Ko, Such Cho, "Soder Joints Inspection Using A Neural Network and Fuzzy Rule-based Classification Method", April 2000, IEEE, vol. 23, no. 2, pgs 93-103
	V	Lei Xu, Adam Krzyzak, "Methods of Combining Multiple Classifiers and Their Applications to Handwriting Recognition", May/June 1992, IEEE, vol. 22, no. 3, pgs. 418-435
	W	Henry, et al, "Application of ADC Techniques to Characterize Yield-Limiting Defects Identified With the Overlay of E-Test/Inspecting Data On Short Loop Process Tester", Sept. 1999, IEEE/SEMI, pgs. 330-337
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.